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Pantic, M.; Rothkrantz, L.J.M.;  
*Systems, Man and Cybernetics, Part B, IEEE Transactions on*  
 Volume 34, Issue 3, June 2004 Page(s):1449 - 1461  
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**2. Facial action detection from dual-view static face images**

Pantic, M.; Rothkrantz, L.;  
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**4. A novel neural network technique for the detection of human faces in visual scenes**

Sarris, N.; Grammalidis, N.; Strintzis, M.G.;  
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**5. Automatic extraction of contour lines and feature points from profile images**

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Byung-Woo Min; He-Sub Yoon; Jung Soh; Young-Kyu Yang;

[Advanced Intelligent Mechatronics '97, IEEE/ASME International Conference on](#)

16-20 June 1997 Page(s):27

Digital Object Identifier 10.1109/AIM.1997.652885

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Ruali, L.; Tesse, M.;

[Intelligent Environments, 2006. IE '06. 2nd IET International Conference on](#)

Volume 2, 5-6 July 2006 Page(s):121 - 129

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